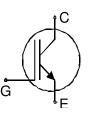


IGBT Chip in NPT-technology

FEATURES:

- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

- This chip is used for:IGBT-Modules
- Applications:
- drives



Chip Type	V_{CE}	I Cn	Die Size	Package	Ordering Code
SIGC156T60NR2C	600V	200A	12.5 x 12.5 mm ²	sawn on foil	Q67050-A4013- A001

MECHANICAL PARAMETER:

Raster size	12.5 x 12.5				
Area total / active	156.25 / 138.2				
Emitter pad size	8x(2.58x4.78)				
Gate pad size	0.8 x 1.46				
Thickness	100	μm			
Wafer size	150	mm			
Flat position	90	deg			
Max.possible chips per wafer	84				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	Al, ≤500µm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t_p limited by T_{jmax}	I _{cpuls}	600	A
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T _j , T _{stg}	-55 +150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
rarameter			min.	typ.	max.	
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V, I _C =5mA	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =200A	1.7	2	2.5	V
Gate-emitter threshold voltage	V _{GE(th)}	I_{C} =4mA, V_{GE} = V_{CE}	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V_{CE} =600V, V_{GE} =0V			13.6	μΑ
Gate-emitter leakage current	I _{GES}	V_{CE} =0V, V_{GE} =20V			600	nA
Integrated gate resistor	R _{Gint}			5		Ω

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
Falameter			min.	typ.	max.	
Input capacitance	Ciss	V _{CE} =25V	-	9000	-	pF
Output capacitance	Coss	$V_{\rm GE}=0$ V	-	tbd	-	
Reverse transfer capacitance	Crss	<i>f</i> =1MHz	-	800	-	

SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

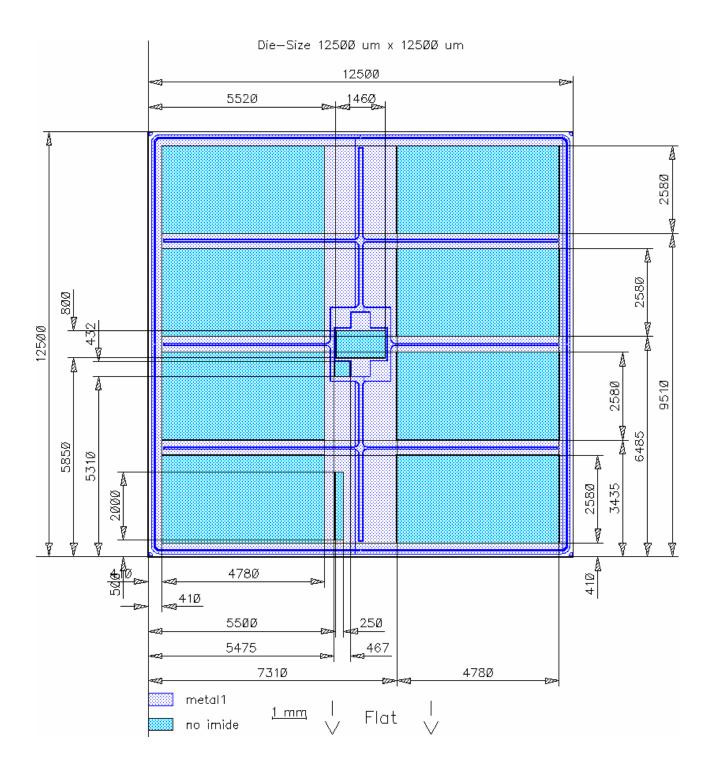
Parameter	Symbol	Conditions ¹⁾	Value			Unit
Falameter			min.	typ.	max.	
Turn-on delay time	t _{d(on)}	T _j =125°C V _{CC} =300V	-	180	-	ns
Rise time	t _r	/ _C =200A	-	49	-	
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE}=\pm 15 \rm V$ $R_{\rm G}=1,5 \Omega$	-	285	-	
Fall time	t _f	16-1,022	-	41	_	

¹⁾ values also influenced by parasitic L- and C- in measurement and package.

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CHIP DRAWING:



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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

BSM 200 GD 60 DLC

Econo Pack 3

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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